

<b>Notice of References Cited</b>	Application/Control No. 10/810,355	Applicant(s)/Patent Under Reexamination BINDEMAN, LEE	
	Examiner Brandon Hsieh	Art Unit 2128	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,044,210	03-2000	Nagtegaal, Joop C.	716/9
*	B	US-6,560,570	05-2003	Dohrmann et al.	703/7
*	C	US-6,697,770	02-2004	Nagetgaal, Joop C.	703/2
*	D	US-2002/0198693	12-2002	Marusich, Troy	703/2
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Forssell et al., Feb 14, 2003, "Creating a New Element Type" <a href="http://web.archive.org/web/20030214185408/http://impact.sourceforge.net/Manual_Programmers/Element.html">http://web.archive.org/web/20030214185408/http://impact.sourceforge.net/Manual_Programmers/Element.html</a>
	V	Belytschko, 1997, Element Technology, <a href="http://www.tam.northwestern.edu/tb/Book/Chapter%208.pdf">http://www.tam.northwestern.edu/tb/Book/Chapter%208.pdf</a> .
	W	Thomas J. R.; "The Finite Element Method Linear Static and Dynamic Finite Element Analysis" P. 123-125, 2000, Dover Publications
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.